

<b>Notice of References Cited</b>	Application/Control No. 09/942,635	Applicant(s)/Patent Under Reexamination CARY ET AL.	
	Examiner Tamara L. Graysay	Art Unit 3623	Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,061,658	05-2000	Chou et al.	705/10
	B	US-5,404,509	04-1995	Klein, Laurence C.	707/101
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 07262061 A	10-1995	Japan	OGAWA et al.	G06F 12/00
	O	JP 11232149 A	08-1999	Japan	OKADA, KANAE	G06F 12/00
	P					
	Q					
	R					
	S					
	T					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Rabianski, The accuracy of economic?demographic projections made by private vendors of secondary data, Appraisal Journal, APR1992, v.60, n.2, p.170-177 (8 pages)
	V	Little, Auditing for database integrity, Journal of Systems Management, AUG1994, v.45, n.8, p.6-10, [online], [retrieved 9/5/2005 via DIALOG file 15:00895469] (8 pages)
	W	Wang, A product perspective on total data quality management, Communications of the ACM, FEB1998, v.41, n.2, p.58-65, [online], [retrieved 9/5/2005 via DIALOG file 15:01569154] (9 pages)
	X	Baker, Mine over matter, Journal of Business Strategy, JUL/AUG1998, v.19, n.4, p.22-26, [online], retrieved 9/5/2005 via DIALOG file 15:01730804] (7 pages)

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.